

SMD AEC-Q200 Qualified Thick Film Chip Resistor

Type CRGCQ series

ENVIRONMENTAL CHARACTERISTICS

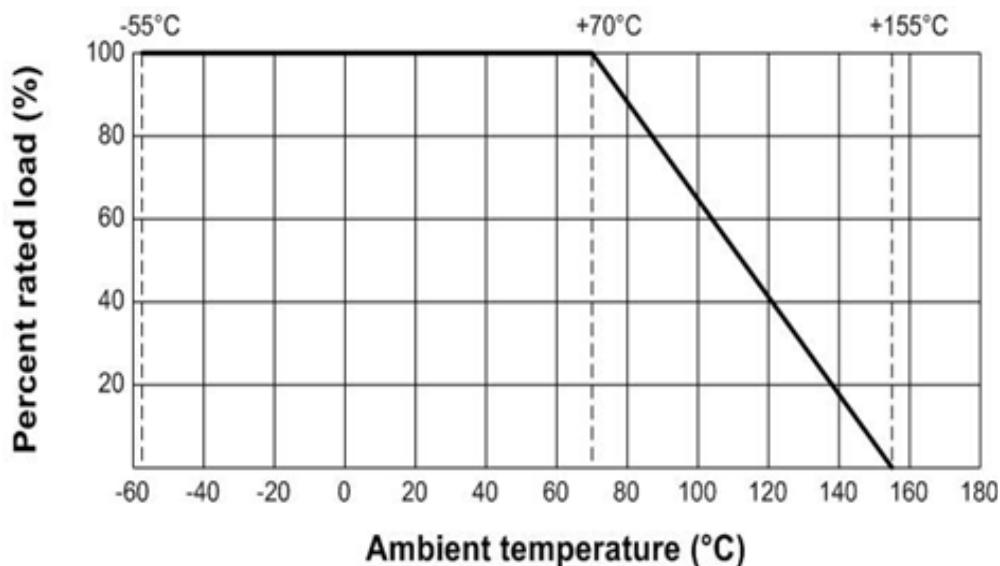
Characteristics	Limits	Test Methods																								
Load life	$\pm 1\%: \pm(1.0\%+0.1\Omega)$ Max. $\pm 5\%: \pm(3.0\%+0.1\Omega)$ Max.	125°C, 35% power, at RCVV or Max. Working Voltage whichever less, 1,000 hours (1.5 hours "ON", 0.5 hours "OFF"), Measurement at 24±2 hours after test conclusion. (MIL-STD-202 Method 108)																								
Temperature coefficient	$1\Omega \leq R \leq 10\Omega: \pm 400\text{PPM}/^{\circ}\text{C}$ $10\Omega < R \leq 100\Omega: \pm 200\text{PPM}/^{\circ}\text{C}$ $R > 100\Omega: \pm 100\text{PPM}/^{\circ}\text{C}$	Measure between -55°C ~+125°C																								
Short-time overload	$\pm 1\%: \pm(1.0\%+0.1\Omega)$ Max. $\pm 5\%: \pm(2.0\%+0.1\Omega)$ Max.	2.5x Rated voltage or Max. Overload Voltage whichever is lower for 5 seconds, then check the resistance.																								
Terminal bending	$\pm(1.0\%+0.05\Omega)$ Max.	Bending Distance 3mm, Duration: 60s±5s, then check the resistance																								
Solderability	95% coverage Min.	245±3°C; 2-3s																								
Soldering heat	$\pm(1.0\%+0.05\Omega)$ Max.	260±5°C; 10±1s																								
Moisture resistance	1%: $\pm(0.5\%+0.1\Omega)$ Max. 5%: $\pm(3.0\%+0.1\Omega)$ Max.	25°C~65°C, 90~100%RH, 2.5Hr; 65°C 90~100%RH, 3Hr; 65°C~25°C 80~100%RH, 2.5Hr, 10 cycles. Measurement at 24 hours after test conclusion (MIL-STD-202 Method 106)																								
Biased humidity	1%: $\pm(1.0\%+0.1\Omega)$ Max. 5%: $\pm(3.0\%+0.1\Omega)$ Max.	10% rated power, 85°C/85%RH, 1000Hr. Measurement at 24 hours after test conclusion. (MIL-STD-202 Method 103)																								
Dielectric withstand voltage	No evidence of flashover, mechanical damage, arcing or insulation breakdown	Resistor shall be clamped in the trough of 90° metallic V-block and shall be tested at AC potential respectively specified in the given list of each product type for 60-70s.																								
Temperature cycling	1%: $\pm(0.5\%+0.1\Omega)$ Max. 5%: $\pm(1.0\%+0.1\Omega)$ Max.	-55±3°C 30min ~normal temperature 10min-15min-155±2°C 30min~normal temperature 10min-15min 1000 cycles. Measurement at 24 hours after test conclusion. (JESD22 Method JA-104)																								
ESD	$\pm(1.0\%+0.05\Omega)$ Max. <table border="1"> <thead> <tr> <th>Chip Size</th> <th>ESD</th> <th>Class</th> </tr> </thead> <tbody> <tr> <td>0402</td> <td>0.6kv</td> <td>1B</td> </tr> <tr> <td>0603</td> <td>1kv</td> <td>1C</td> </tr> <tr> <td>0805</td> <td>1.3kv</td> <td>1C</td> </tr> <tr> <td>1206</td> <td>2.1kv</td> <td>2</td> </tr> <tr> <td>1210</td> <td>3.9kv</td> <td>2</td> </tr> <tr> <td>2010</td> <td>10kv</td> <td>5A</td> </tr> <tr> <td>2512</td> <td>17kv</td> <td>5C</td> </tr> </tbody> </table>	Chip Size	ESD	Class	0402	0.6kv	1B	0603	1kv	1C	0805	1.3kv	1C	1206	2.1kv	2	1210	3.9kv	2	2010	10kv	5A	2512	17kv	5C	With the electrometer in direct contact with the discharge tip, verify the voltage setting at levels of ±500V, ±1KV, ±2KV, ±4KV, ±8KV, The electrometer reading shall be within ±10% for voltages from 500V to ≤800V. (AEC-Q200-002)
Chip Size	ESD	Class																								
0402	0.6kv	1B																								
0603	1kv	1C																								
0805	1.3kv	1C																								
1206	2.1kv	2																								
1210	3.9kv	2																								
2010	10kv	5A																								
2512	17kv	5C																								
Sulfuration test	1%: $\pm(1.0\%+0.1\Omega)$ Max. 5%: $\pm(5.0\%+0.1\Omega)$ Max.	H2S 3~5PPM 50°C±2°C 91%~93% RH 1000H																								

SMD AEC-Q200 Qualified Thick Film Chip Resistor

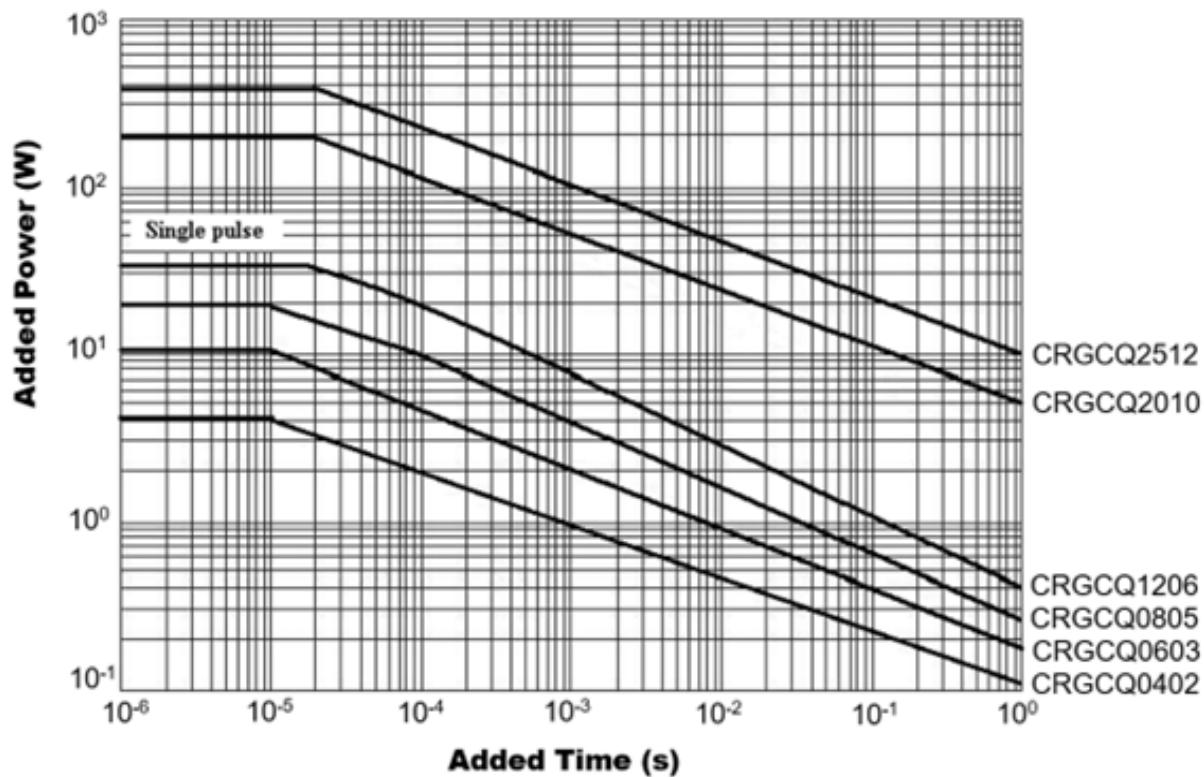
Type CRGCQ series

POWER DERATING CURVE

Power rating based on continuous load operation in ambient temperature of -55 - 70°C. For resistors operated in ambient temperatures above 70°C, power rating must be derated in accordance with this curve.



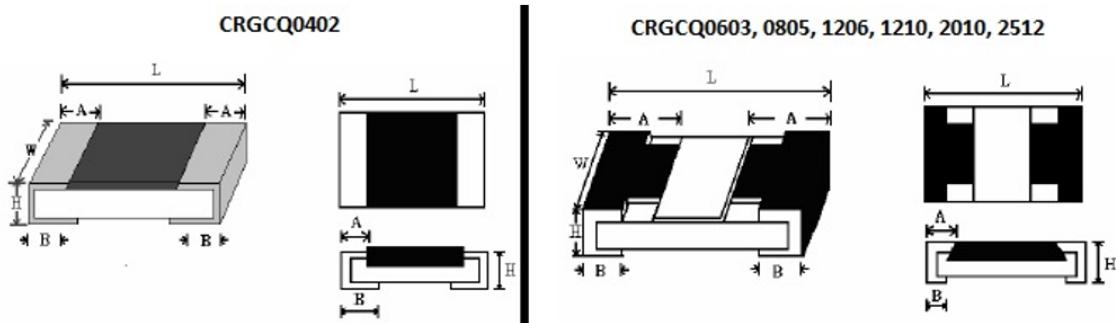
PULSE CHARACTERISTICS



SMD AEC-Q200 Qualified Thick Film Chip Resistor

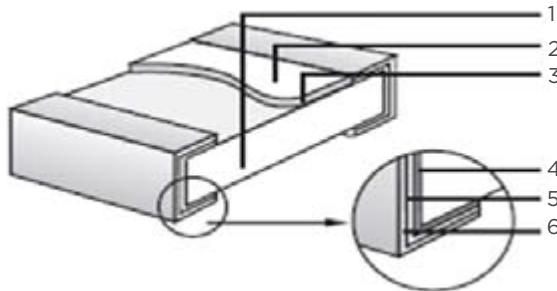
Type CRGCQ series

DIMENSIONS



Type	Dimension (mm)				
	L	W	H	A	B
CRGCQ0402	1.00±0.10	0.50±0.05	0.35±0.05	0.20±0.10	0.25±0.10
CRGCQ0603	1.60±0.10	0.80±0.10	0.45±0.10	0.30±0.20	0.30±0.20
CRGCQ0805	2.00±0.15	1.25+0.15/-0.10	0.55±0.10	0.40±0.20	0.40±0.20
CRGCQ1206	3.10±0.15	1.55+0.15/-0.10	0.55±0.10	0.45±0.20	0.45±0.20
CRGCQ1210	3.10±0.10	2.60±0.20	0.55±0.10	0.50±0.25	0.50±0.20
CRGCQ2010	5.00±0.10	2.50±0.20	0.55±0.10	0.60±0.25	0.50±0.20
CRGCQ2512	6.35±0.10	3.20±0.20	0.55±0.10	0.60±0.25	0.50±0.20

CONSTRUCTION



1. High purity alumina substrate
2. Protective coating
3. Resistive element
4. Termination (inner) Ni/Cr
5. Termination (between) Ni Barrier
6. Termination (outer) Sn

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POWER RATING AND RESISTANCE RANGE

Type	Power Rating @ 70°C	Tolerance	Resistance Range	Standard Series
CRGCQ0402	0.0625W	Jumper	< 50mΩ	
		±1%	1R0 - 10M	E24
		±5%	1R0 - 10M	E96 by negotiation
CRGCQ0603	0.1W	Jumper	< 50mΩ	
		±1%	1R0 - 10M	E24
		±5%	1R0 - 10M	E96 by negotiation
CRGCQ0805	0.125W	Jumper	< 50mΩ	
		±1%	1R0 - 10M	E24
		±5%	1R0 - 10M	E96 by negotiation
CRGCQ1206	0.25W	Jumper	< 50mΩ	
		±1%	1R0 - 10M	E24
		±5%	1R0 - 10M	E96 by negotiation
CRGCQ1210	0.5W	Jumper	< 50mΩ	
		±1%	1R0 - 10M	E24
		±5%	1R0 - 10M	E96 by negotiation
CRGCQ2010	0.75W	Jumper	< 50mΩ	
		±1%	1R0 - 10M	E24
		±5%	1R0 - 10M	E96 by negotiation
CRGCQ2512	1W	Jumper	< 50mΩ	
		±1%	1R0 - 10M	E24
		±5%	1R0 - 10M	E96 by negotiation

MARKING

E24 series 0603 – 2512 3 Digits – first two digits denote significant figures of resistance and third digit denotes number of zeros thereafter. EG

	2	2
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=
2K2

Marking for E96 Series 0805 – 2512 4 digits – First three digits denote significant figures of resistance and fourth digit denotes number of zeros thereafter. EG.

	1	0	0
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=
100R

For ohmic values below 100R letter “R” denotes decimal point. EG

	1	R	8	0
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=
1R8 / 1.8Ω

0402 size chips are not marked

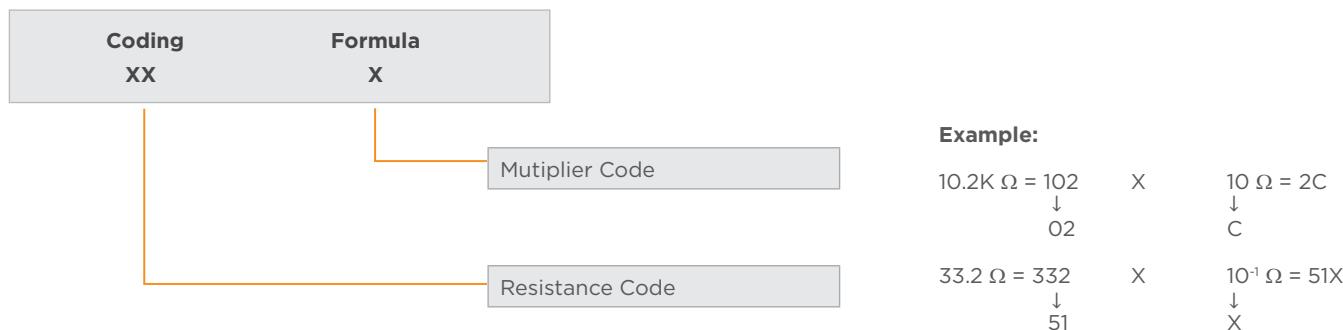
0603 E96 3 digit marking.

SMD AEC-Q200 Qualified Thick Film Chip Resistor

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MUTIPLIER CODE

Code	A	B	C	D	E	F	G	H	X	Y	Z
Multiplier	10^0	10^1	10^2	10^3	10^4	10^5	10^6	10^7	10^{-1}	10^{-2}	10^{-3}



Value	Code	Value	Code	Value	Code	Value	Code
100	01	191	28	365	55	698	82
102	02	196	29	374	56	715	83
105	03	200	30	383	57	732	84
107	04	205	31	392	58	750	85
110	05	210	32	402	59	768	86
113	06	215	33	412	60	787	87
115	07	221	34	422	61	806	88
118	08	226	35	432	62	825	89
121	09	232	36	442	63	845	90
124	10	237	37	453	64	866	91
127	11	243	38	464	65	887	92
130	12	249	39	475	66	909	93
133	13	255	40	487	67	931	94
137	14	261	41	499	68	953	95
140	15	267	42	511	69	976	96
143	16	274	43	523	70		
147	17	280	44	536	71		
150	18	287	45	549	72		
154	19	294	46	562	73		
158	20	301	47	576	74		
162	21	309	48	590	75		
165	22	316	49	604	76		
169	23	324	50	619	77		
174	24	332	51	634	78		
178	25	340	52	649	79		
182	26	348	53	665	80		
187	27	357	54	681	81		

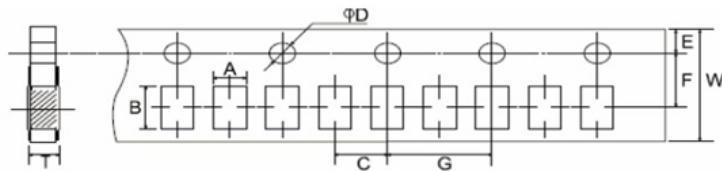
Marking for E96 series 0603 size with no marking code marked as per E24 values.

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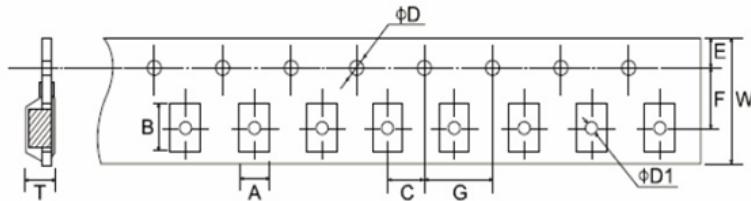
PACKAGING SPECIFICATION

Paper taping



Type	A ± 0.2	B ± 0.2	C ± 0.05	ØD +0.1 -0	E ± 0.1	F ± 0.05	G ± 0.1	W ± 0.2	T ± 0.1
0402	0.65	1.15	2.0	1.5	1.75	3.5	4.0	8.0	0.45
0603	1.10	1.90	2.0	1.5	1.75	3.5	4.0	8.0	0.67
0805	1.65	2.40	2.0	1.5	1.75	3.5	4.0	8.0	0.81
1206	2.00	3.60	2.0	1.5	1.75	3.5	4.0	8.0	0.81
1210	2.80	3.50	2.0	1.5	1.75	3.5	4.0	8.0	0.75
2010	2.80	5.40	2.0	1.5	1.75	3.5	4.0	12.0	0.75

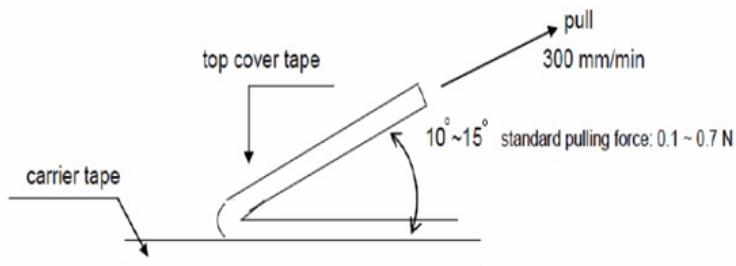
Embossed Taping



Type	A ± 0.2	B ± 0.2	C ± 0.05	ØD +0.1 -0	ØD1 +0.1 -0	E ± 0.1	F ± 0.05	G ± 0.1	W ± 0.2	T ± 0.1
2512	3.50	6.70	2.0	1.5	1.5	1.75	5.5	4.0	12.0	1.0

Peeling strength of cover tape:

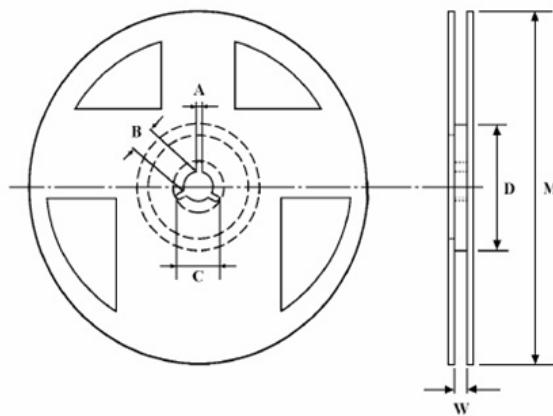
Test condition: 0.1 to 0.7 N at a peel off speed of 300mm / min.



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REEL DIMENSIONS (mm)

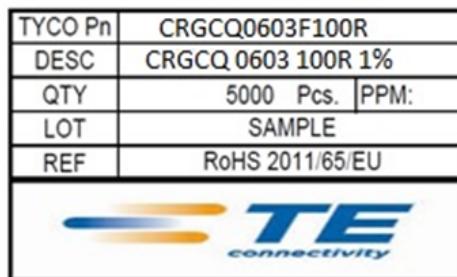


Type	Tape	Reel Qty	A ± 0.5	B ± 0.5	C ± 0.5	D ± 1	M ± 2	W ± 1
0402	Paper	10,000	2	13	21	60	178	10
0603	Paper	5,000	2	13	21	60	178	10
0805	Paper	5,000	2	13	21	60	178	10
1206	Paper	5,000	2	13	21	60	178	10
1210	Paper	5,000	2	13	21	60	178	10
2010	Paper	4,000	2	13	21	60	178	13.8
2512	Embossed	4,000	2	13	21	60	178	13.8

LABEL

1. TE Product Number
2. Product Description
3. Quantity
4. Lot Number
5. RoHS Statement

Example



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ENVIRONMENT RELATED SUBSTANCE

This product complies to EU RoHS directive, EU PAHs directive, EU PFOS directive and Halogen free.

OZONE LAYER DEPLETING SUBSTANCES

Ozone depleting substances are not used in our manufacturing process of this product.

This product is not manufactured using Chloro fluorocarbons (CFCs), Hydrochlorofluorocarbons (HCFCs), Hydrobromofluorocarbons (HBFCs) or other ozone depleting substances in any phase of the manufacturing process.

STORAGE CONDITION (MSL1)

The performance of these products, including the solderability, is guaranteed for a year from the date of arrival at your company, provided that they remain packed as they were when delivered and stored at a temperature of $25^{\circ}\text{C} \pm 10^{\circ}\text{C}$ and a relative humidity of $60\%\text{RH} \pm 10\%\text{RH}$, chemical and dust free atmosphere

Even within the above guarantee periods, do not store these products in the following conditions otherwise, their electrical performance and/or solderability may be deteriorated, and the packaging materials (e.g. taping materials) may be deformed or deteriorated, resulting in mounting failures.

1. In salty air or in air with a high concentration of corrosive gas, such as Cl_2 , H_2S , NH_3 , SO_2 , or NO_2
2. In direct sunlight

SOLDER PROFILE

Wave soldering condition: (2 cycles Max.)

Pre-heat : $100 \sim 120^{\circ}\text{C}$, 30 ± 5 sec.

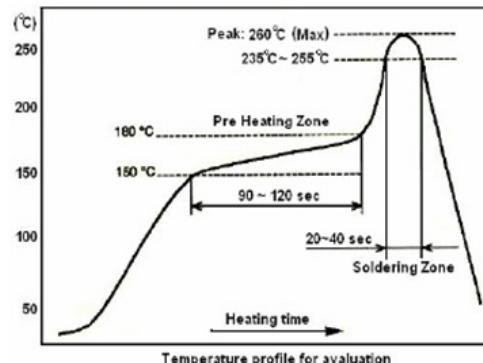
Peak temp.: 260°C

Reflow soldering condition: (2 cycles Max.)

Pre-heat : $150 \sim 180^{\circ}\text{C}$, $90 \sim 120$ sec.

Suggestion solder temp.: $235 \sim 255^{\circ}\text{C}$, $20 \sim 40$ sec.

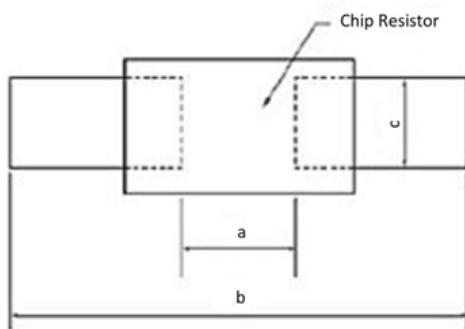
Peak temp.: 260°C



Hand Soldering condition:

The Soldering iron tip should be less than 300°C and maximum contact time should be 5 seconds.

RECOMMENDED PCB LAYOUT PLAN



Type	a (mm)	b (mm)	c (mm)
0402	0.45 to 0.55	1.35 to 1.45	0.45 to 0.55
0603	0.85 to 0.95	2.05 to 2.15	0.75 to 0.85
0805	0.90 to 1.10	2.90 to 3.10	1.20 to 1.40
1206	1.90 to 2.10	4.10 to 4.30	1.50 to 1.70
1210	1.90 to 2.10	4.10 to 4.30	2.50 to 2.70
2010	3.50 to 3.70	6.10 to 6.30	2.50 to 2.70
2512	4.90 to 5.10	8.10 to 8.30	3.20 to 3.40

ORDERING INFORMATION

		Part Number			
		CRGCQ	0603	J	10K
Common Part					
CRGCQ	AEC-Q200 Qualified Thick Film Chip Resistor				
Size					
0402					
0603					
0805					
1206					
1210					
2010					
2512					
Tolerance					
F	±1%				
J	±5%				
Resistance Value					
1 ohm	(1Ω) 1R0				
1K ohm	(1000Ω) 1KO				
100K ohm	(100000Ω) 100K				
1M ohm	(1000000Ω) 1MO				

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